





60V P-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(on)}	I _D T _A = 25°C		
-60V	125mΩ @ V _{GS} = -10V	-4.3A		
-60 V	190mΩ @ V _{GS} = -4.5V	-3.5A		

Description and Applications

This MOSFET has been designed to minimize the on-state resistance and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Motor control
- DC-DC Converters
- Power management functions
- Uninterrupted power supply

Features and Benefits

- · Fast switching speed
- Low gate drive
- Low input capacitance
- "Green" component and RoHS compliant (Note 1)
- Qualified to AEC-Q101 Standards for High Reliability

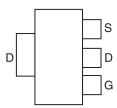
Mechanical Data

- Case: SOT-223
- Case Material: Molded Plastic, UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin annealed over Copper lead frame.
 Solderable per MIL-STD-202, Method 208
- Weight: 0.112 grams (approximate)

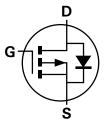
SOT223



Top View



Pin Out - Top View



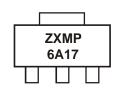
Equivalent Circuit

Ordering Information (Note 1)

ĺ	Product	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
	ZXMP6A17GTA	See below	7	12	1,000

Note: 1. Diodes, Inc. defines "Green" products as those which are RoHS compliant and contain no halogens or antimony compounds; further information about Diodes Inc.'s "Green" Policy can be found on our website. For packaging details, go to our website.

Marking Information



ZXMP = Product Type Marking Code, Line 1 6A17 = Product Type Marking Code, Line 2





Maximum Ratings @TA = 25°C unless otherwise specified

	Characteristic		Symbol	Value	Unit
Drain-Source voltage			V_{DSS}	-60	V
Gate-Source voltage			V_{GS}	±20	V
		(Note 3)	I _D	-4.3	
Continuous Drain current	$V_{GS} = 10V$	$T_A = 70$ °C (Note 3)		-3.5	Α
		(Note 2)		-3.0	
Pulsed Drain current V _{GS} = 10V		(Note 4)	I_{DM}	-13.7	Α
Continuous Source current (Body diode) (Note 3)		(Note 3)	Is	-4.8	Α
Pulsed Source current (Body diode) (Note 4)		(Note 4)	I _{SM}	-13.7	Α

Thermal Characteristics $@T_A = 25^{\circ}C$ unless otherwise specified

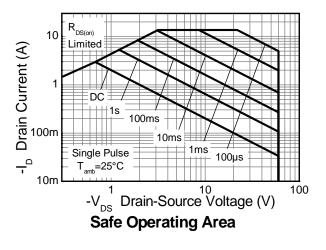
Characteristic	Symbol	Value	Unit	
Power dissipation	(Note 2)	,	2.0 16	W
Linear derating factor	(Note 3)	P _D	3.9 31	mW/°C
Thermal Resistance, Junction to Ambient	(Note 2)	D	62.5	
Thermal Resistance, Junction to Ambient	(Note 3)	R_{\thetaJA}	32.0	°C/W
Thermal Resistance, Junction to Lead	(Note 5)	$R_{ hetaJL}$	9.8	
Operating and storage temperature range		T _J , T _{STG}	-55 to 150	°C

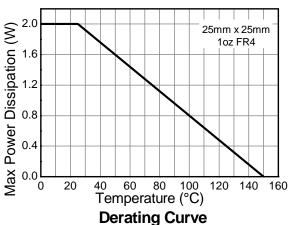
Notes:

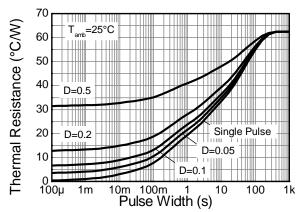
- 2. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
- 3. Same as note (2), except the device is measured at t ≤ 10 sec.
 4. Same as note (2), except the device is pulsed with D= 0.02 and pulse width 300 µs. The pulse current is limited by the maximum junction temperature.
- 5. Thermal resistance from junction to solder-point (at the end of the drain lead).

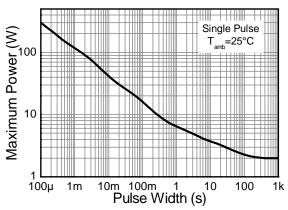


Thermal Characteristics









Transient Thermal Impedance

Pulse Power Dissipation





Electrical Characteristics @T_A = 25°C unless otherwise specified

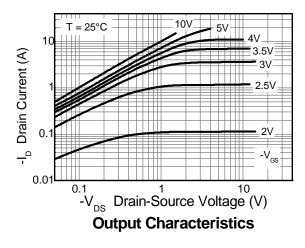
Characteristic	Symbol	Min	Тур	Max	Unit	Test C	ondition	
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage	BV _{DSS}	-60			V	$I_D = -250 \mu A, V_{GS} = 0 V$		
Zero Gate Voltage Drain Current	I _{DSS}	_	_	-0.5	μΑ	$V_{DS} = -60V, V_{GS}$	= 0V	
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS}$	S = 0V	
ON CHARACTERISTICS								
Gate Threshold Voltage	$V_{GS(th)}$	-1.0	_	_	V	$I_D = -250 \mu A, V_{DS}$	$S = V_{GS}$	
Ctatic Dunin Courses On Bonisten on (Note C)			0.096	0.125	Ω	V _{GS} = -10V, I _D = -2.2A		
Static Drain-Source On-Resistance (Note 6)	RDS (ON)	_	0.120	0.190	Ω	$V_{GS} = -4.5V, I_D =$: -1.8A	
Forward Transconductance (Notes 6 & 7)	g _{fs}	_	4.7	_	S	$V_{DS} = -15V, I_{D} =$	-2.2A	
Diode Forward Voltage (Note 6)	V _{SD}	_	-0.85	-0.95	V	I _S = -2.0A, V _{GS} =	0V, T _J = 25°C	
Reverse recovery time (Note 7)	t _{rr}		25.1	_	ns	$I_S = -1.7A$, di/dt =	= 100A/μs,	
Reverse recovery charge (Note 7)	Q_{rr}	_	27.2	_	nC	T _J = 25°C		
DYNAMIC CHARACTERISTICS (Note 7)								
Input Capacitance	C _{iss}	_	637	_	pF		2) /	
Output Capacitance	Coss	_	70.0	_	pF	V _{DS} = -30V, V _{GS} = 0V f = 1MHz		
Reverse Transfer Capacitance	C _{rss}	_	53.0	_	pF	T = TIVITIZ		
Total Gate Charge (Note 8)	Qg	_	9.0	_	nC	$V_{GS} = -4.5V$		
Total Gate Charge (Note 8)	Qq	_	17.7	_	nC		V _{DS} = -30V	
Gate-Source Charge (Note 8)	Q _{gs}	_	1.6	_	nC	V _{GS} = -10V	$I_D = -2.2A$	
Gate-Drain Charge (Note 8)	Q_{qd}	_	4.4	_	nC			
Turn-On Delay Time (Note 8)	t _{D(on)}	_	2.6	_	ns			
Turn-On Rise Time (Note 8)	t _r	_	3.4	_	ns	V _{DD} = -30V, V _{GS} = -10V		
Turn-Off Delay Time (Note 8)	t _{D(off)}	_	26.2	_	ns	$I_D = -1A, R_G \cong 6.0\Omega$		
Turn-Off Fall Time (Note 8)	t _f		11.3	_	ns	<u> </u>		

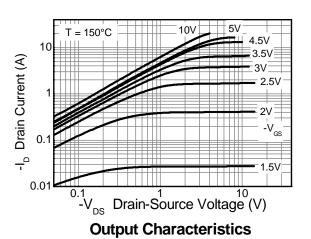
Notes:

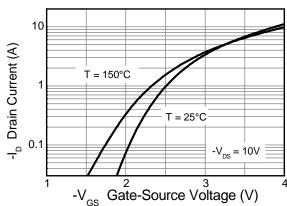
- 6. Measured under pulsed conditions. Pulse width ≤ 300µs; duty cycle ≤ 2%
 7. For design aid only, not subject to production testing.
 8. Switching characteristics are independent of operating junction temperatures.

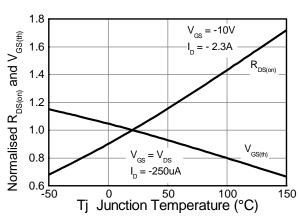


Typical Characteristics



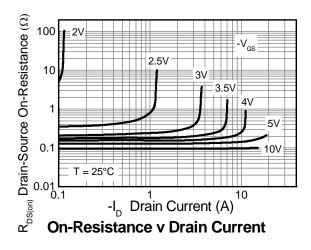


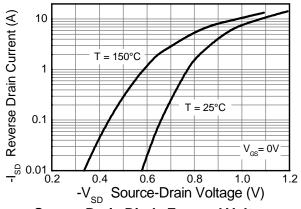




Typical Transfer Characteristics

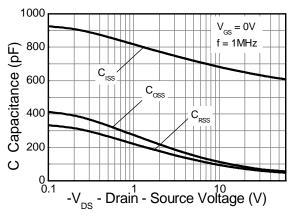
Normalised Curves v Temperature



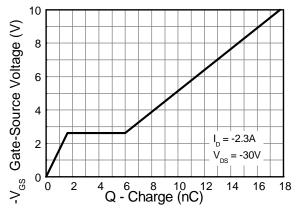




Typical Characteristics – continued

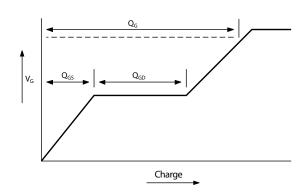


Capacitance v Drain-Source Voltage

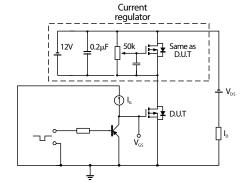


Gate-Source Voltage v Gate Charge

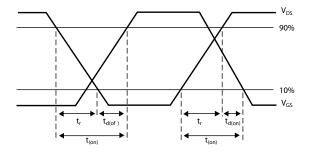
Test Circuits



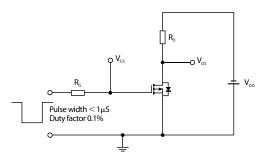
Basic gate charge waveform



Gate charge test circuit



Switching time waveforms

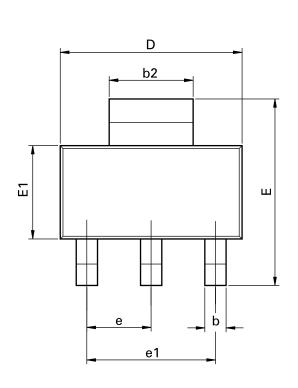


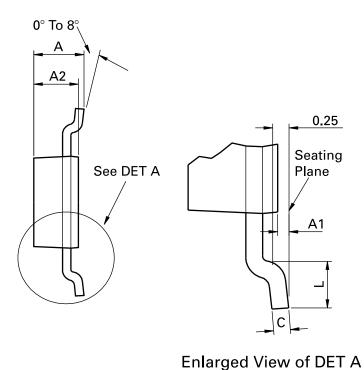
Switching time test circuit





Package Outline Dimensions



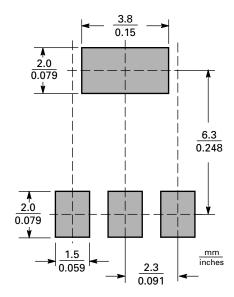


Conforms to JEDEC TO-261 AA Issue B

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min	Max	Min	Max		Min	Max	Min	Max
Α	-	1.80	-	0.071	D	6.30	6.70	0.248	0.264
A1	0.02	0.10	0.0008	0.004	е	2.30	BSC	0.0905 BSC	
A2	1.55	1.65	0.0610	0.0649	e1	4.60 BSC		0.181 BSC	
b	0.66	0.84	0.026	0.033	Е	6.70	6.70 7.30		0.287
b2	2.90	3.10	0.114	0.122	E1	3.30	3.70	0.130	0.146
С	0.23	0.33	0.009	0.013	L	0.90	-	0.355	-



Suggested Pad Layout



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